Notice of References Cited Application/Control No. 09/909,281 Applicant(s)/Patent Under Reexamination HUTHWOHL ET AL. Examiner Hien Tran Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-----------------|----------------|
| | Α | US-5,089,237 | 02-1992 | Schuster et al. | 422/180 |
| | В | US-5,682,740 | 11-1997 | Kawamura, Hideo | 60/297 |
| | C | US-5,863,311 | 01-1999 | Nagai et al. | 55/483 |
| | D | US-5,766,455 | 06-1998 | Berman et al. | 210/199 |
| | Е | US-6,284,201 | 09-2001 | Buck, Alfred | 422/177 |
| | F | US- | | | |
| | G | US- | | · | |
| | H | US- | | | |
| | 1 | US- | | | |
| | ٦ | US- | | | |
| | К | US- | | | |
| | L | US- | | | |
| | М | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
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| | a | | | | | |
| | R | | | | | |
| | S | | | | | |
| | Т | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) | | | | | |
|---|---|---|--|--|--|--|--|
| | U | | | | | | |
| | V | | | | | | |
| | w | | | | | | |
| | Х | | | | | | |

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